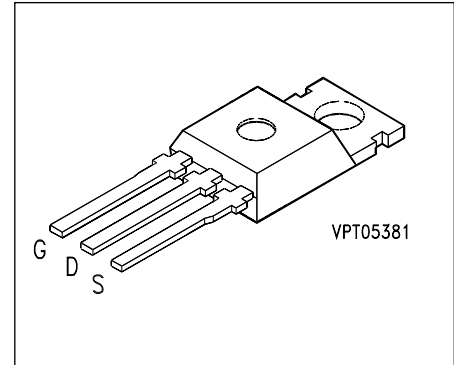


## SIPMOS® Power Transistors

**BUZ 92**  
**BUZ 93**

- N channel
- Enhancement mode
- Avalanche-rated



Type	$V_{DS}$	$I_D$	$R_{DS(on)}$	Package <sup>1)</sup>	Ordering Code
<b>BUZ 92</b>	600 V	3.3 A	3.0 $\Omega$	TO-220 AB	C67078-S1343-A2
<b>BUZ 93</b>	600 V	3.6 A	2.5 $\Omega$	TO-220 AB	C67078-S1346-A2

### Maximum Ratings

Parameter	Symbol	BUZ		Unit
		92	93	
Continuous drain current, $T_C = 25\text{ }^\circ\text{C}$	$I_D$	<b>3.3</b>	<b>3.6</b>	A
Pulsed drain current, $T_C = 25\text{ }^\circ\text{C}$	$I_{D\text{ puls}}$	<b>13</b>	<b>14.5</b>	
Avalanche current, limited by $T_{j\text{ max}}$	$I_{AR}$	<b>3.3</b>		
Avalanche energy, periodic limited by $T_{j\text{ (max)}}$	$E_{AR}$	<b>6</b>		mJ
Avalanche energy, single pulse $I_D = 3.3\text{ A}$ , $V_{DD} = 50\text{ V}$ , $R_{GS} = 25\text{ }\Omega$ $L = 37\text{ mH}$ , $T_j = 25\text{ }^\circ\text{C}$	$E_{AS}$	<b>220</b>		
Gate-source voltage	$V_{GS}$	<b><math>\pm 20</math></b>		V
Power dissipation, $T_C = 25\text{ }^\circ\text{C}$	$P_{tot}$	<b>80</b>		W
Operating and storage temperature range	$T_j, T_{stg}$	<b><math>- 55 \dots + 150</math></b>		$^\circ\text{C}$
Thermal resistance, chip-case	$R_{th\text{ JC}}$	<b><math>\leq 1.56</math></b>		K/W
DIN humidity category, DIN 40 040		<b>E</b>		–
IEC climatic category, DIN IEC 68-1		<b>55/150/56</b>		

1) See chapter Package Outlines.

## Electrical Characteristics

at  $T_j = 25\text{ °C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

### Static characteristics

Drain-source breakdown voltage $V_{GS} = 0\text{ V}, I_D = 0.25\text{ mA}$	$V_{(BR)DSS}$	600	–	–	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = 1\text{ mA}$	$V_{GS(th)}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$ $T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$	$I_{DSS}$	– –	0.1 10	1.0 100	$\mu\text{A}$
Gate-source leakage current $V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$	$I_{GSS}$	–	10	100	nA
Drain-source on-resistance $V_{GS} = 10\text{ V}, I_D = 2.0\text{ A}$	$R_{DS(on)}$	– –	2.6 2.0	3.0 2.5	$\Omega$
					BUZ 92 BUZ 93

### Dynamic characteristics

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}, I_D = 2.0\text{ A}$	$g_{fs}$	2.1	3.0	–	S
Input capacitance $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	$C_{iss}$	–	600	900	pF
Output capacitance $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	$C_{oss}$	–	65	100	
Reverse transfer capacitance $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	$C_{rss}$	–	25	40	
Turn-on time $t_{on}$ , ( $t_{on} = t_{d(on)} + t_r$ ) $V_{DD} = 30\text{ V}, V_{GS} = 10\text{ V}, I_D = 2.3\text{ A}, R_{GS} = 50\text{ }\Omega$	$t_{d(on)}$	–	10	15	ns
	$t_r$	–	50	70	
Turn-off time $t_{off}$ , ( $t_{off} = t_{d(off)} + t_f$ ) $V_{DD} = 30\text{ V}, V_{GS} = 10\text{ V}, I_D = 2.3\text{ A}, R_{GS} = 50\text{ }\Omega$	$t_{d(off)}$	–	70	95	
	$t_f$	–	40	55	

## Electrical Characteristics (cont'd)

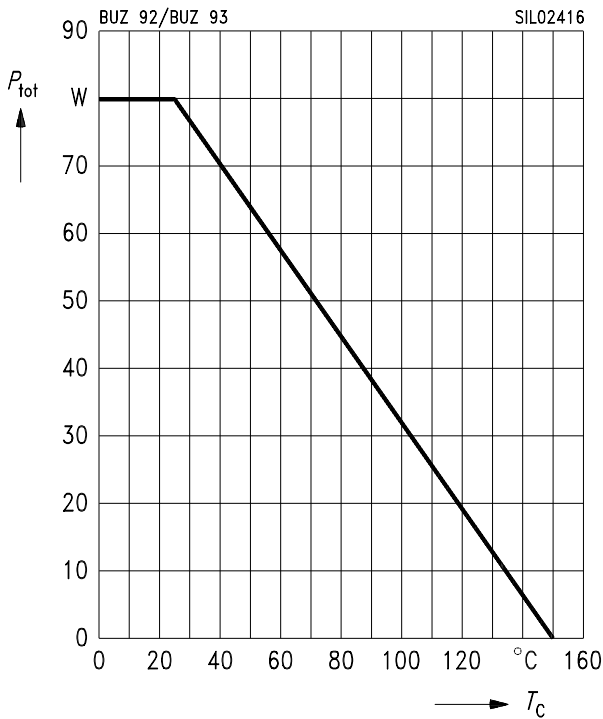
at  $T_j = 25\text{ °C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Reverse diode</b>					
Continuous reverse drain current $T_C = 25\text{ °C}$	$I_S$				A
BUZ 92		–	–	3.3	
BUZ 93		–	–	3.6	
Pulsed reverse drain current $T_C = 25\text{ °C}$	$I_{SM}$				
BUZ 92		–	–	13	
BUZ 93		–	–	14.5	
Diode forward on-voltage $I_S = 6.6\text{ A}$ , $V_{GS} = 0\text{ V}$	$V_{SD}$	–	1.0	1.4	V
Reverse recovery time $V_R = 100\text{ V}$ , $I_F = I_S$ , $di_F / dt = 100\text{ A}/\mu\text{s}$	$t_{rr}$	–	300	–	ns
Reverse recovery charge $V_R = 100\text{ V}$ , $I_F = I_S$ , $di_F / dt = 100\text{ A}/\mu\text{s}$	$Q_{rr}$	–	2.5	–	$\mu\text{C}$

Characteristics at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

### Total power dissipation

$$P_{\text{tot}} = f(T_C)$$

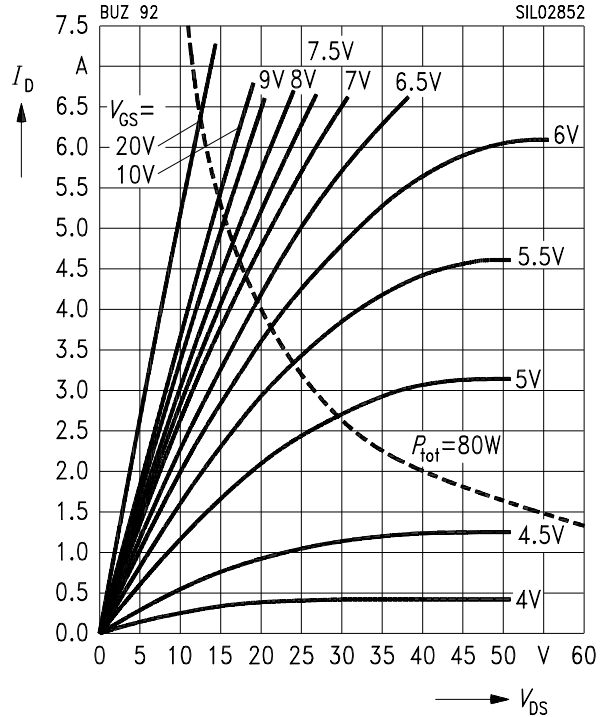


### Typ. output characteristics

$$I_D = f(V_{\text{DS}})$$

parameter:  $t_p = 80 \mu\text{s}$

BUZ 92

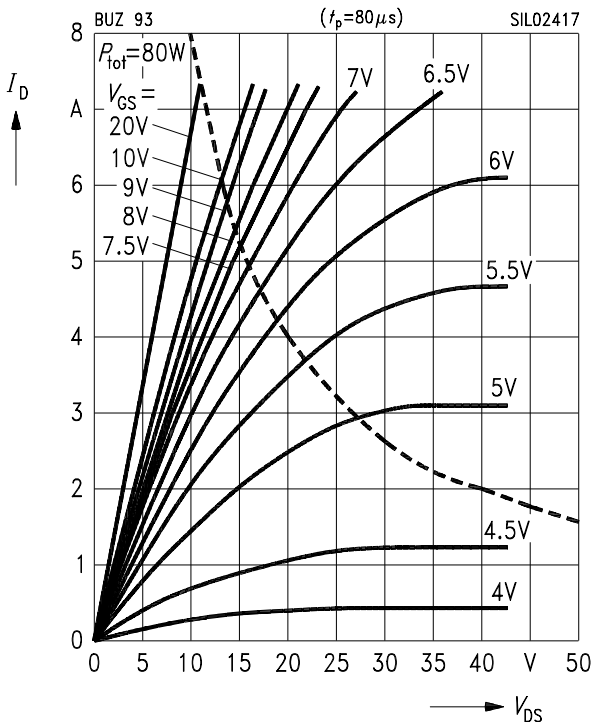


### Typ. output characteristics

$$I_D = f(V_{\text{DS}})$$

parameter:  $t_p = 80 \mu\text{s}$

BUZ 93

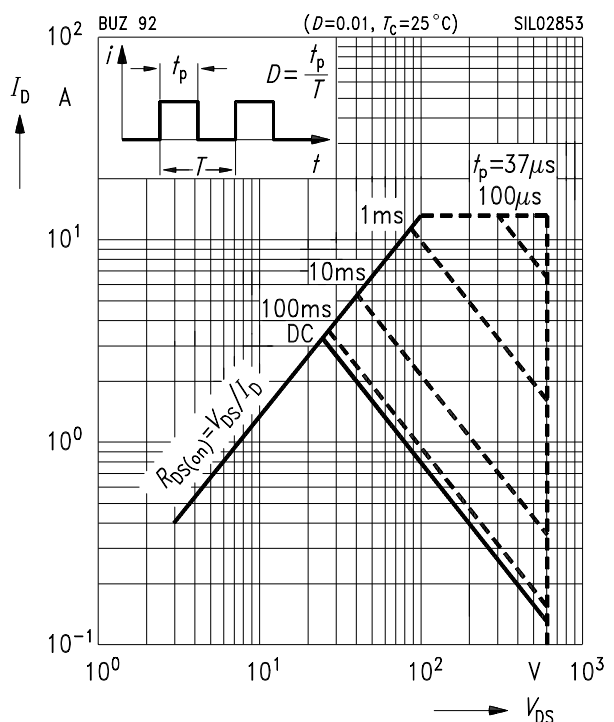


### Safe operating area

$$I_D = f(V_{\text{DS}})$$

parameter:  $D = 0.01, T_C = 25^\circ\text{C}$

BUZ 92

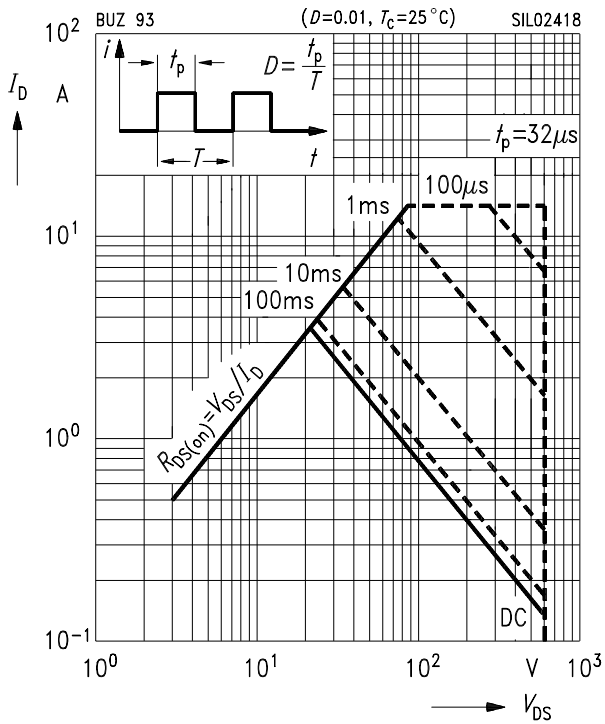


### Safe operating area

$$I_D = f(V_{DS})$$

BUZ 93

parameter:  $D = 0.01, T_C = 25^\circ\text{C}$

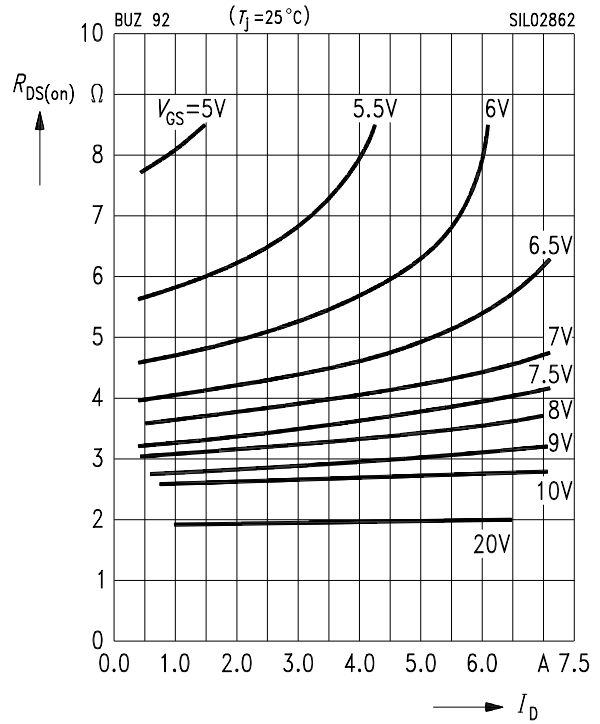


### Typ. drain-source on-resistance

$$R_{DS(on)} = f(I_D)$$

BUZ 92

parameter:  $V_{GS}$

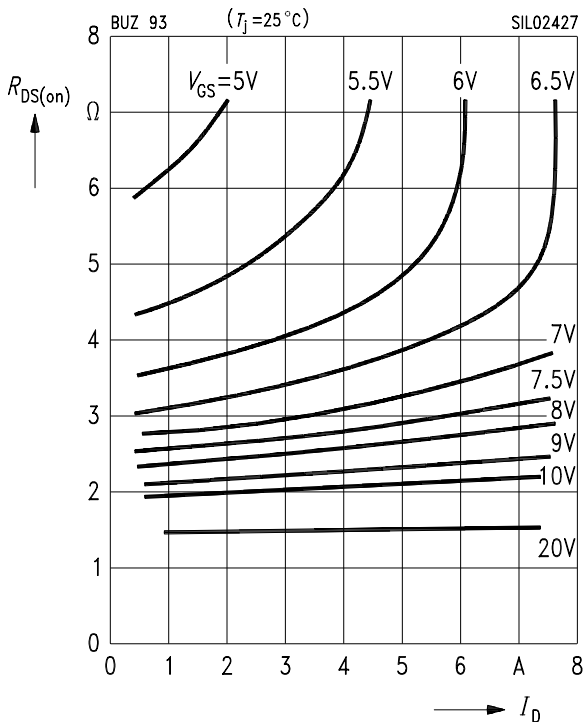


### Typ. drain-source on-resistance

$$R_{DS(on)} = f(I_D)$$

BUZ 93

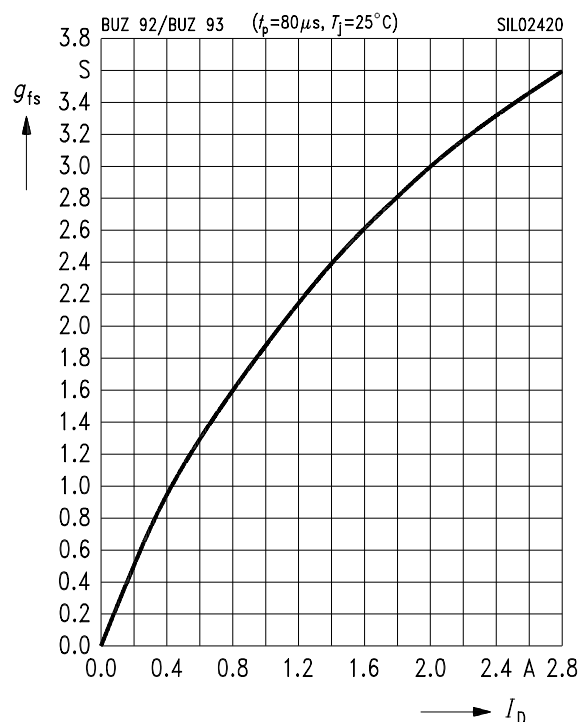
parameter:  $V_{GS}$



### Typ. forward transconductance

$$g_{fs} = f(I_D)$$

parameter:  $t_p = 80 \mu\text{s}$

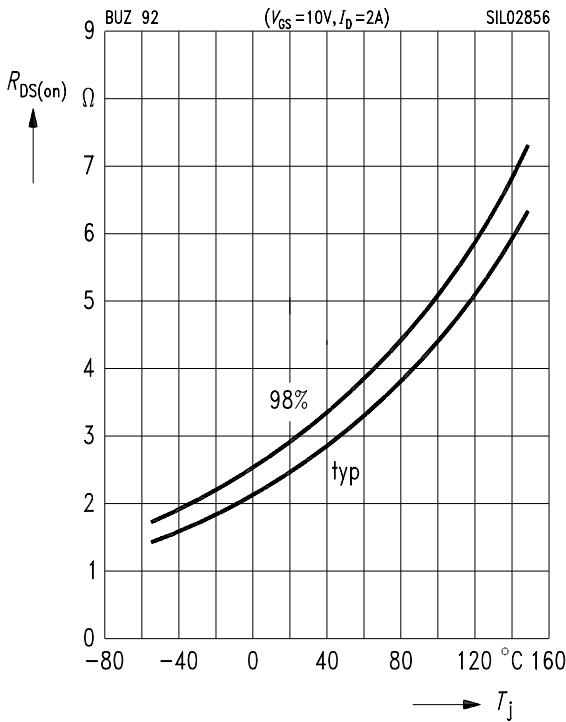


### Drain-source on-resistance

$$R_{DS(on)} = f(T_j)$$

parameter:  $I_D = 2\text{ A}$ ,  $V_{GS} = 10\text{ V}$ , (spread)

**BUZ 92**

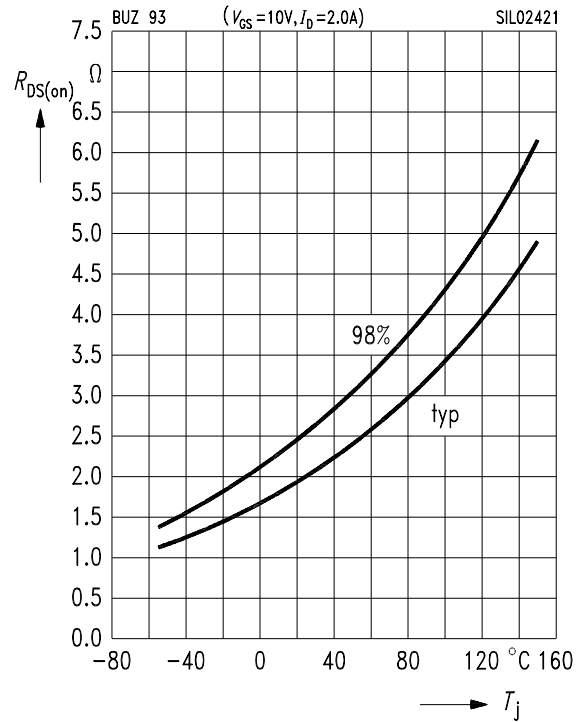


### Drain-source on-resistance

$$R_{DS(on)} = f(T_j)$$

parameter:  $I_D = 2\text{ A}$ ,  $V_{GS} = 10\text{ V}$ , (spread)

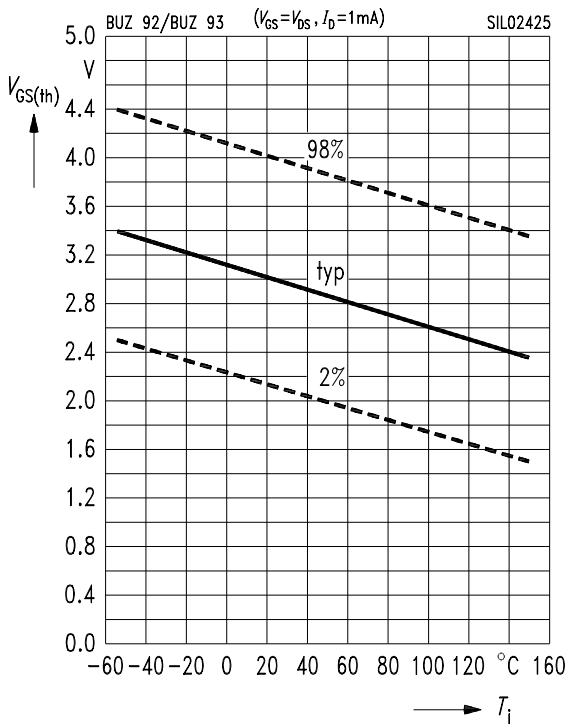
**BUZ 93**



### Gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

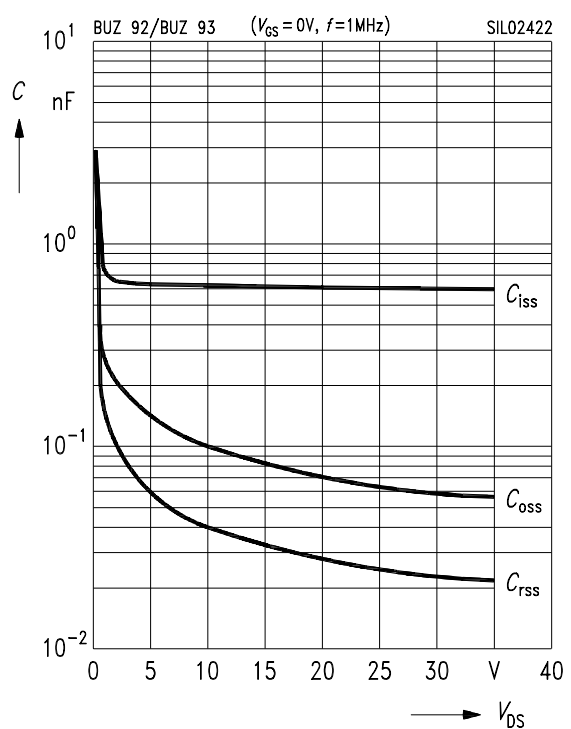
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1\text{ mA}$ , (spread)



### Typ. capacitances

$$C = f(V_{DS})$$

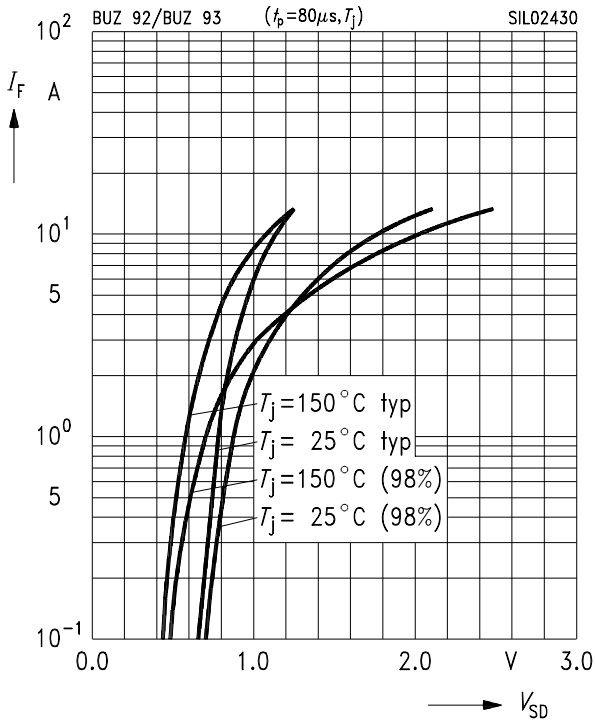
parameter:  $V_{GS} = 0\text{ V}$ ,  $f = 1\text{ MHz}$



**Forward characteristics of reverse diode**

$I_F = f(V_{SD})$

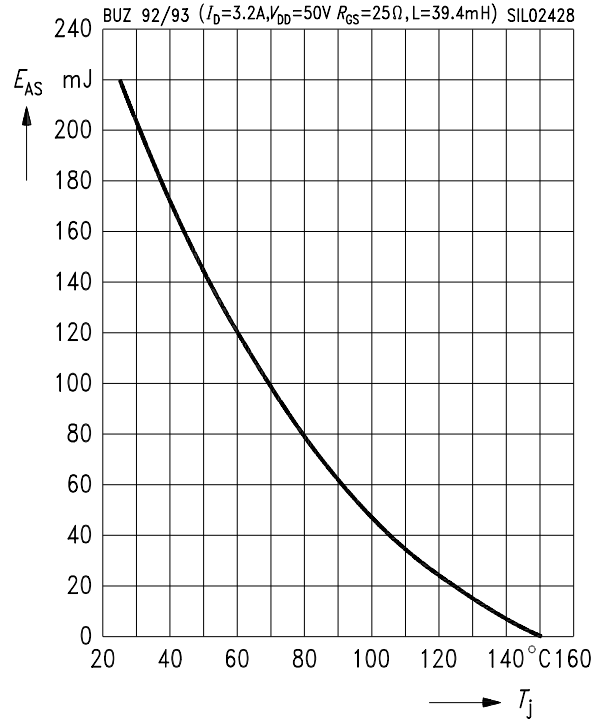
parameter:  $T_j, t_p = 80 \mu s$ , (spread)



**Avalanche energy  $E_{AS} = f(T_j)$**

parameter:  $I_D = 3.2 A, V_{DD} = 50 V$

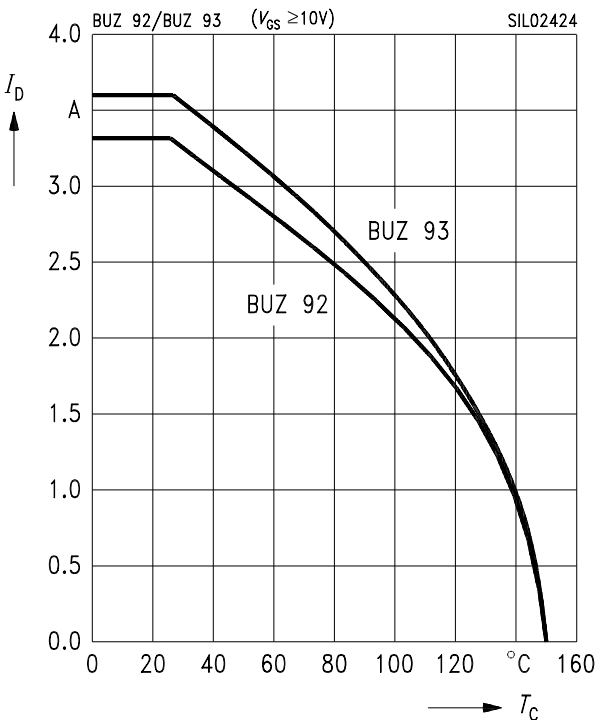
$R_{GS} = 25 \Omega, L = 39.4 mH$



**Drain current**

$I_D = f(T_C)$

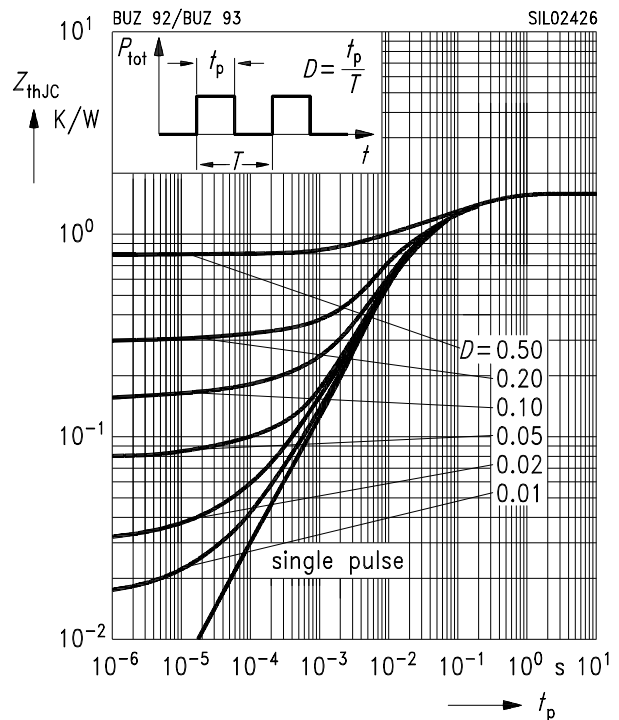
parameter:  $V_{GS} \geq 10 V$



**Transient thermal impedance**

$Z_{thJC} = f(t_p)$

parameter:  $D = t_p / T$



### Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

parameter:  $I_{D\ puls} = 4.8\ A$

